





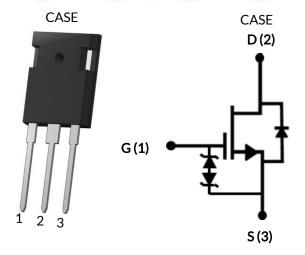








UF3SC120016K3S



| Part Number | Package | Marking | | |
|----------------|-----------|----------------|--|--|
| UF3SC120016K3S | TO-247-3L | UF3SC120016K3S | | |









1200V-16m Ω SiC FET

Rev. B, December 2019

Description

This SiC FET device is based on a unique 'cascode' circuit configuration, in which a normally-on SiC JFET is co-packaged with a Si MOSFET to produce a normally-off SiC FET device. The device's standard gate-drive characteristics allows for a true "drop-in replacement" to Si IGBTs, Si FETs, SiC MOSFETs or Si superjunction devices. Available in the TO-247-3L package, this device exhibits ultralow gate charge and exceptional reverse recovery characteristics, making it ideal for switching inductive loads when used with recommended RC-snubbers, and any application requiring standard gate drive.

Features

- Typical on-resistance $R_{DS(on),typ}$ of $16m\Omega$
- Maximum operating temperature of 175°C
- Excellent reverse recovery
- Low gate charge
- Low intrinsic capacitance
- ESD protected, HBM class 2
- Very low switching losses (required RC-snubber loss negligible under typical operating conditions)

Typical applications

- EV charging
- PV inverters
- Switch mode power supplies
- Power factor correction modules
- Motor drives
- Induction heating













Maximum Ratings

| Parameter | Symbol | Test Conditions | Value | Units |
|---|------------------|-------------------------------|------------|-------|
| Drain-source voltage | V_{DS} | | 1200 | V |
| Gate-source voltage | V_{GS} | DC | -20 to +20 | V |
| Continuous drain current ¹ | | T _C = 25°C | 107 | Α |
| Continuous drain current | I _D | T _C = 100°C | 77 | Α |
| Pulsed drain current ² | I _{DM} | T _C = 25°C | 350 | Α |
| Single pulsed avalanche energy ³ | E _{AS} | L=15mH, I _{AS} =6.6A | 327 | mJ |
| Power dissipation | P _{tot} | T _C = 25°C | 517 | W |
| Maximum junction temperature | $T_{J,max}$ | | 175 | °C |
| Operating and storage temperature | T_J, T_{STG} | | -55 to 175 | °C |
| Max. lead temperature for soldering, 1/8" from case for 5 seconds | T _L | | 250 | °C |

- 1. Limited by $T_{J,\text{max}}$
- 2. Pulse width t_p limited by $T_{J,max}$
- 3. Starting $T_J = 25^{\circ}C$

Thermal Characteristics

| Parameter | Symbol | Test Conditions | Value | | | - Units |
|--------------------------------------|---------------|-----------------|-------|------|------|---------|
| | | | Min | Тур | Max | Offics |
| Thermal resistance, junction-to-case | $R_{	heta$ JC | | | 0.22 | 0.29 | °C/W |













Electrical Characteristics (T_J = +25°C unless otherwise specified)

Typical Performance - Static

| Parameter | Symbol | Test Conditions | | Value | | | |
|--------------------------------|---------------------|--|------|-------|-----|-------|--|
| | Syllibol | | Min | Тур | Max | Units | |
| Drain-source breakdown voltage | BV _{DS} | V_{GS} =0V, I_D =1mA | 1200 | | | V | |
| Total drain leakage current | | V _{DS} =1200V, V _{GS} =0V, T _J =25°C | | 1.2 | 300 | μΑ | |
| | I _{DSS} | V _{DS} =1200V, V _{GS} =0V, T _J =175°C | | 3.7 | | | |
| Total gate leakage current | I _{GSS} | V _{DS} =0V, T _J =25°C, V _{GS} =-20V / +20V | | 4.5 | ±20 | μА | |
| Drain-source on-resistance | R _{DS(on)} | V_{GS} =12V, I_D =50A, T_J =25°C | | 16 | 21 | | |
| | | V _{GS} =12V, I _D =50A, T _J =125°C | | 25 | | mΩ | |
| | | V _{GS} =12V, I _D =50A, T _J =175°C | | 33 | | | |
| Gate threshold voltage | $V_{G(th)}$ | V_{DS} =5V, I_{D} =10mA | 4 | 4.7 | 6 | ٧ | |
| Gate resistance | R _G | f=1MHz, open drain | | 0.8 | 1.5 | Ω | |

Typical Performance - Reverse Diode

| Parameter | Symbol | Test Conditions | | Units | | |
|---|-----------------|--|-----|-------|-----|------------|
| | | Test Conditions | Min | Тур | Max | Units |
| Diode continuous forward current ¹ | I _S | T _C =25°C | | | 107 | Α |
| Diode pulse current ² | $I_{S,pulse}$ | T _C =25°C | | | 350 | Α |
| Forward voltage | V_{FSD} | V _{GS} =0V, I _F =50A, T _J =25°C | | 1.47 | 2 | V |
| rorwaru voitage | | V _{GS} =0V, I _F =50A, T _J =175°C | | 1.95 | | - v |
| Reverse recovery charge | Q _{rr} | V_R =800V, I_F =80A, V_{GS} =-5V, R_{G_LEXT} =5 Ω | | 605 | | nC |
| Reverse recovery time | t _{rr} | di/dt=1750A/μs, T _J =25°C | | 66 | | ns |
| Reverse recovery charge | Q _{rr} | V_R =800V, I_F =80A, V_{GS} =-5V, R_{G_LEXT} =5 Ω | | 621 | | nC |
| Reverse recovery time | t _{rr} | di/dt=1750A/μs, Τ _J =150°C | | 72 | | ns |













Typical Performance - Dynamic

| Parameter | Symbol | Symbol Test Conditions | | Value | | | |
|---|----------------------|---|-----|-------|-----|-------|--|
| r ai ailletei | Зуппоп | Test conditions | Min | Тур | Max | Units | |
| Input capacitance | C _{iss} | V _{DS} =800V, V _{GS} =0V | | 7824 | | | |
| Output capacitance | C _{oss} | f=100kHz | | 216 | | pF | |
| Reverse transfer capacitance | C_{rss} | 1-100KH2 | | 3.1 | | | |
| Effective output capacitance, energy related | C _{oss(er)} | V _{DS} =0V to 800V, V _{GS} =0V | | 243 | | pF | |
| Effective output capacitance, time related | C _{oss(tr)} | V _{DS} =0V to 800V, V _{GS} =0V | | 540 | | pF | |
| C _{OSS} stored energy | E _{oss} | V _{DS} =800V, V _{GS} =0V | | 78 | | μJ | |
| Total gate charge | Q_{G} | \/ 000\/ L 00A | | 218 | | - | |
| Gate-drain charge | Q_{GD} | V_{DS} =800V, I_{D} =80A, V_{GS} = -5V to 15V | | 24 | | nC | |
| Gate-source charge | Q_{GS} | V _{GS} = -3V to 13V | | 96 | | | |
| Turn-on delay time | t _{d(on)} | | | 44 | | | |
| Rise time | t _r | V _{DS} =800V, I _D =80A, Gate | | 75 | | ns | |
| Turn-off delay time | t _{d(off)} | Driver =-5V to +15V, | | 121 | | | |
| Fall time | t _f | Turn-on $R_{G,EXT}$ =3.2 Ω , | | 26 | | | |
| Turn-on energy including R _S energy ⁴ | E _{ON} | Turn-off $R_{G,EXT}$ =10 Ω Inductive Load, | | 3290 | | | |
| Turn-off energy including R _S energy ⁴ | E _{OFF} | FWD: same device with | | 660 | | 7 | |
| Total switching energy including R _s energy ⁴ | E _{TOTAL} | V_{GS} = -5V and R_{G} = 10Ω , RC snubber: R_{S} =5 Ω and | | 3950 | | μJ | |
| Snubber R _S energy during turn-on | E _{RS_ON} | C _S =680pF, T _J =25°C | | 22 | | _ | |
| Snubber R _S energy during turn-off | E _{RS_OFF} | | | 76.5 | | | |
| Turn-on delay time | t _{d(on)} | | | 39 | | | |
| Rise time | t _r | V _{DS} =800V, I _D =80A, Gate | | 83 | | ne | |
| Turn-off delay time | t _{d(off)} | Driver =-5V to +15V, | | 128 | | ns | |
| Fall time | t _f | Turn-on $R_{G,EXT} = 3.2\Omega$, | | 29 | | 1 | |
| Turn-on energy including R _S energy ⁴ | E _{ON} | Turn-off $R_{G,EXT}$ =10 Ω Inductive Load, | | 3353 | | | |
| Turn-off energy including R _S energy ⁴ | E _{OFF} | FWD: same device with V_{GS} = -5V and R_{G} = 10 Ω , RC snubber: R_{S} =5 Ω and C_{S} =680pF, T_{J} =150°C | | 670 | | | |
| Total switching energy including R _S energy ⁴ | E _{TOTAL} | | | 4023 | | μЈ | |
| Snubber R _S energy during turn-on | E _{RS_ON} | | | 19 | | | |
| Snubber R _S energy during turn-off | E _{RS_OFF} | | | 72 | | | |

^{4.} The switching performance are evaluated with a RC snubber circuit as shown in Figure 24.













Typical Performance - Dynamic (continued)

| Parameter | Symbol | Symbol Test Conditions | Value | | | Units |
|------------------------|---------------------|--|-------|------|-----|-------|
| | Syllibol | rest Conditions | Min | Тур | Max | UTILS |
| Turn-on delay time | t _{d(on)} | | | 40 | | |
| Rise time | t _r | V_{DS} =800V, I_{D} =80A, Gate | | 63 | | |
| Turn-off delay time | $t_{d(off)}$ | Driver =-5V to +15V, Turn-on $R_{G.EXT}$ =3.2 Ω , | | 119 | | ns |
| Fall time | t _f | Turn-off $R_{G,EXT}$ =10 Ω | | 14 | | |
| Turn-on energy | E _{ON} | Inductive Load, | | 2102 | | |
| Turn-off energy | E _{OFF} | FWD: UJ3D1250K T _I =25°C | | 400 | | μJ |
| Total switching energy | E _{TOTAL} | - 1 _J -23 C | | 2502 | | |
| Turn-on delay time | t _{d(on)} | | | 43 | | |
| Rise time | t _r | V_{DS} =800V, I_{D} =80A, Gate | | 72 | | |
| Turn-off delay time | t _{d(off)} | Driver =-5V to +15V, Turn-on $R_{G.EXT}$ =3.2 Ω , | | 129 | | ns |
| Fall time | t _f | Turn-off $R_{G,EXT}$ = $J_{G,EXT}$ = J_{G,EX | | 14 | | |
| Turn-on energy | E _{ON} | | | 2315 | | |
| Turn-off energy | E _{OFF} | | | 440 | | μJ |
| Total switching energy | E _{TOTAL} | | | 2755 | | |





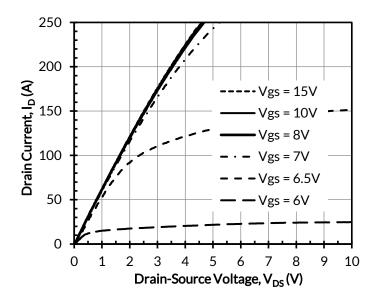








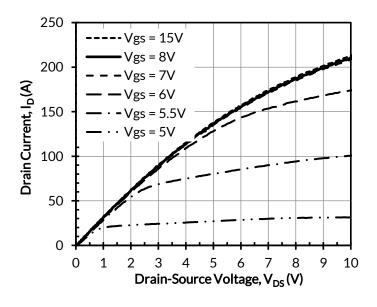
Typical Performance Diagrams



250 200 Drain Current, I_D (A) 150 Vgs = 15V · Vgs = 10V Vgs = 8V 100 **-** Vgs = 7V • Vgs = 6.5V 50 - Vgs = 6V 0 0 1 2 3 5 10 Drain-Source Voltage, V_{DS} (V)

Figure 1. Typical output characteristics at T_J = - 55°C, tp < 250 μ s

Figure 2. Typical output characteristics at $T_J = 25$ °C, tp < 250 μ s



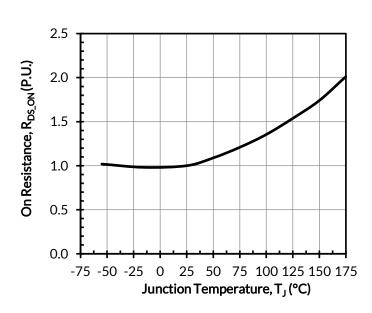


Figure 3. Typical output characteristics at T_J = 175°C, tp < 250 μ s

Figure 4. Normalized on-resistance vs. temperature at V_{GS} = 12V and I_{D} = 50A



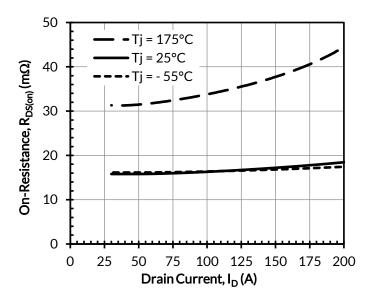








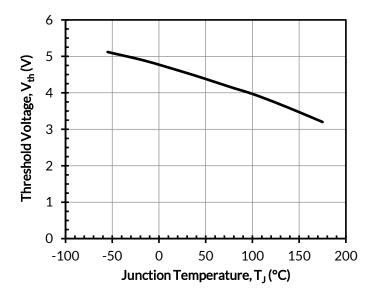




Tj = -55°C Tj = 25°C Drain Current, I_D (A) Tj = 175°C Gate-Source Voltage, $V_{GS}(V)$

Figure 5. Typical drain-source on-resistances at V_{GS} = 12V

Figure 6. Typical transfer characteristics at V_{DS} = 5V



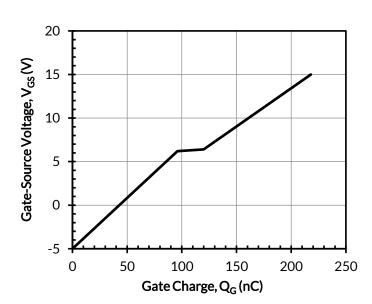


Figure 7. Threshold voltage vs. junction temperature at V_{DS} = 5V and I_{D} = 10mA

Figure 8. Typical gate charge at V_{DS} = 800V and I_{D} = 80A













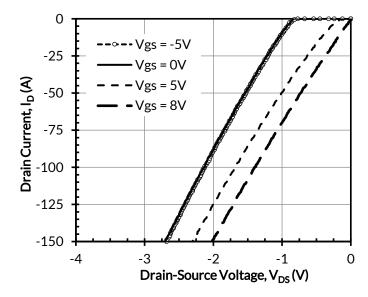


Figure 9. 3rd quadrant characteristics at $T_J = -55$ °C

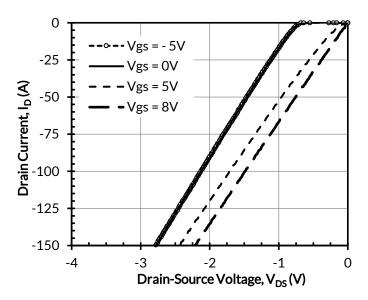


Figure 10. 3rd quadrant characteristics at T_J = 25°C

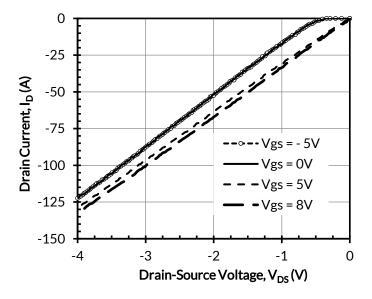


Figure 11. 3rd quadrant characteristics at $T_J = 175$ °C

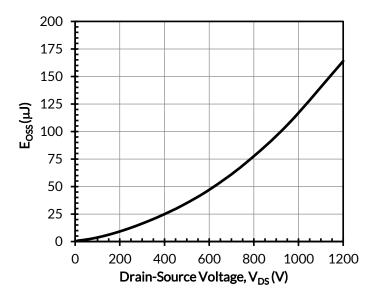


Figure 12. Typical stored energy in C_{OSS} at $V_{GS} = 0V$



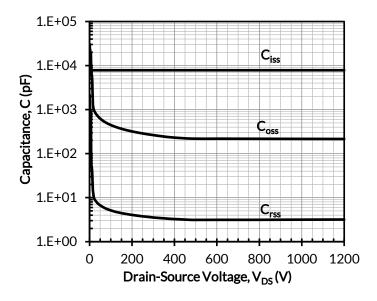








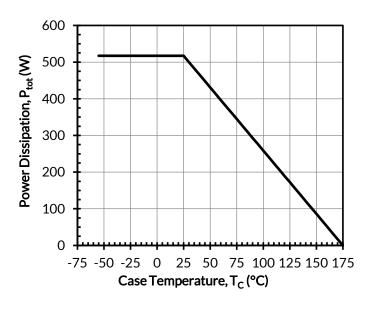




120 100 80 40 20 -75 -50 -25 0 25 50 75 100 125 150 175 Case Temperature, T_C (°C)

Figure 13. Typical capacitances at f = 100kHz and $V_{GS} = 0V$

Figure 14. DC drain current derating



1.E+00

1.E-01

1.E-02

1.E-02

1.E-03

1.E-03

1.E-04

1.E-04

1.E-06

1.E-05

1.E-04

1.E-04

1.E-05

1.E-04

1.E-07

1.E-08

1.E-08

1.E-09

Figure 15. Total power dissipation

Figure 16. Maximum transient thermal impedance



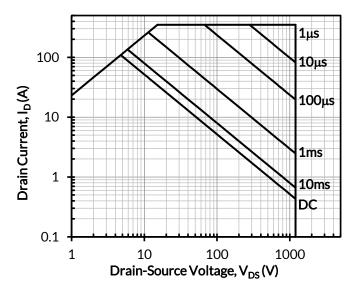








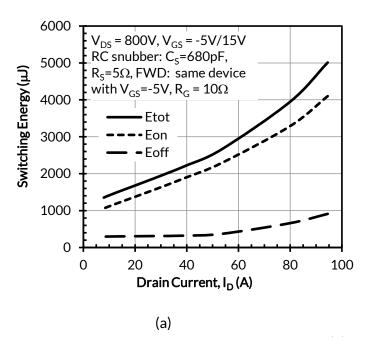




700 600 500 400 300 $V_{DS} = 800V, I_{S} = 80A,$ 200 $di/dt = 1750A/\mu s$, $V_{GS} = -5V, R_G = 5\Omega$ 100 0 0 25 50 75 100 125 150 175 Junction Temperature, T_J (°C)

Figure 17. Safe operation area at $T_C = 25$ °C, D = 0, Parameter t_p

Figure 18. Reverse recovery charge Qrr vs. junction temperture



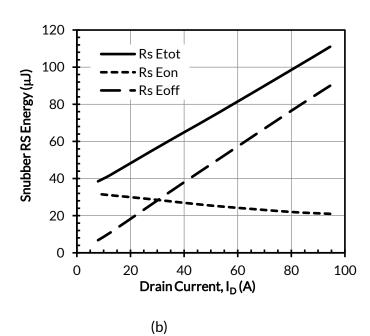


Figure 19. Clamped inductive switching energy (a) and RC snubber energy loss (b) vs. drain current at TJ = 25°C, turn-on R_{G_EXT} = 3.2 Ω , and turn-off R_{G_EXT} = 10 Ω



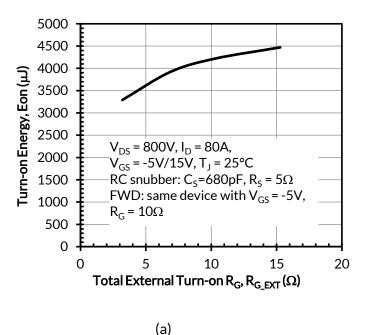












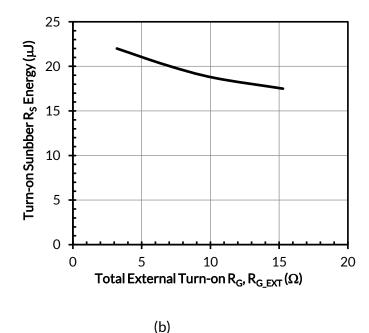
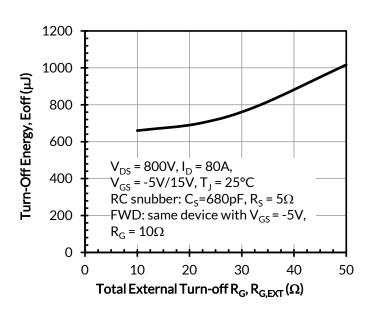
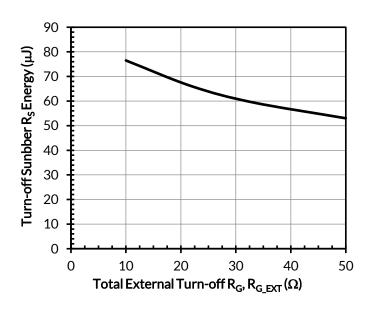


Figure 20. Clamped inductive switching turn-on energy including RC snubber energy loss (a) and RC snubber energy loss (b) as a function of total external turn-on gate resistor R_{G_EXT}



(a)



(b)

Figure 21. Clamped inductive switching turn-off energy including RC snubber energy loss (a) and RC snubber energy loss (b) as a function of total external turn-off gate resistor $R_{G,EXT}$



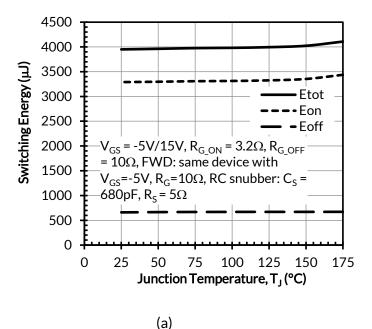












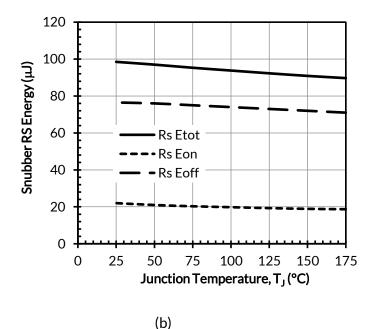
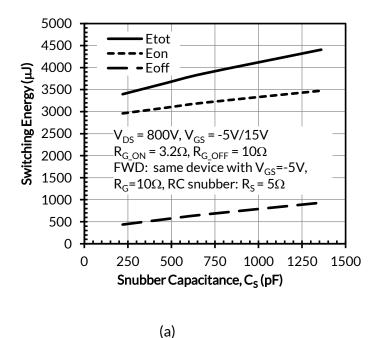


Figure 22. Clamped inductive switching energy including RC snubber energy loss (a) and RC snubber energy loss (b) as a function of junction temperature at V_{DS} = 800V and I_D = 80A



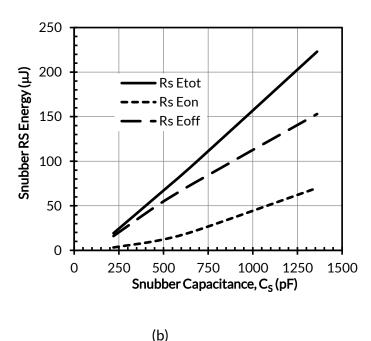


Figure 23. Clamped inductive switching energy including RC snubber energy loss (a) and RC snubber energy loss (b) as a function of snubber capacitance at I_D = 80A and T_J = 25°C













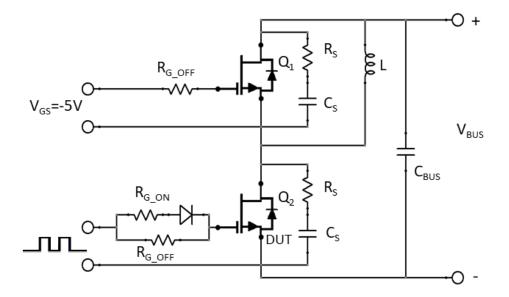
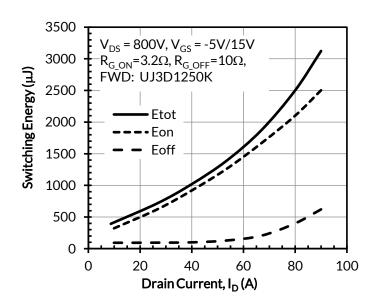


Figure 24. Clamped inductive load switching test circuit An RC snubber ($R_S = 5\Omega$ and $C_S = 680$ pF) is required to improve the turn-off waveforms.



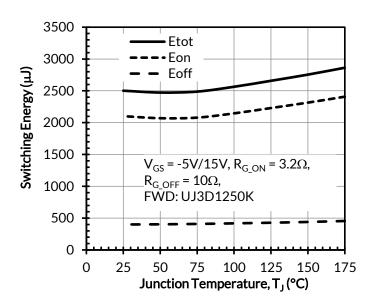


Figure 25. Clamped inductive switching energy vs. drain current without RC snubber at $T_J = 25^{\circ}\text{C}$

Figure 26. Clamped inductive switching energy vs. junction temperature without RC snubber at V_{DS} = 800V and I_D = 80A













Applications Information

SiC FETs are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ($R_{\rm DS(on)}$), output capacitance ($C_{\rm oss}$), gate charge ($Q_{\rm G}$), and reverse recovery charge (Qrr) leading to low conduction and switching losses. The SiC FETs also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the FET is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on SiC FET operation, see www.unitedsic.com.

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